

# TYPES 2N2646, 2N2647 P-N PLANAR SILICON UNIJUNCTION TRANSISTORS

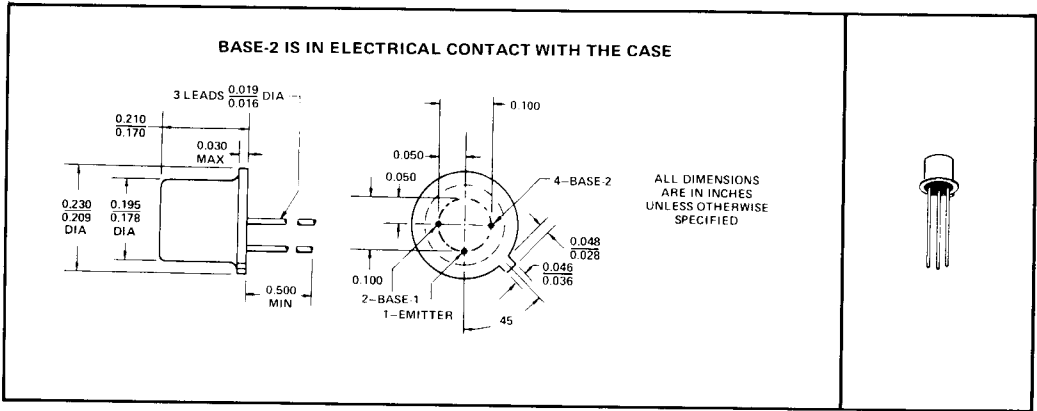
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## PLANAR UNIJUNCTION TRANSISTORS SPECIFICALLY CHARACTERIZED FOR A WIDE RANGE OF MILITARY AND INDUSTRIAL APPLICATIONS

- Planar Process Ensures Low Leakage, Low Drive-Current Requirement, and Improved Reliability

**\*mechanical data**

Package outline is the same as JEDEC TO-18 except for lead position. All TO-18 registration notes also apply to this outline.



**\*absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)**

Emitter—Base-Two Reverse Voltage . . . . .	-30 V
Interbase Voltage (See Note 1) . . . . .	35 V
Continuous Emitter Current . . . . .	50 mA
Peak Emitter Current (See Note 2) . . . . .	2 A
Continuous Device Dissipation at (or below) 25°C Free-Air Temperature (See Note 3) . . . . .	300 mW
Storage Temperature Range . . . . .	-65°C to 150°C
Lead Temperature 1/16 Inch from Case for 10 Seconds . . . . .	260°C

- NOTES: 1. This rating is based upon allowable power dissipation:  $V_{B2B1} = \sqrt{r_{BB} \cdot P_T}$ .
2. This value applies for a capacitor discharge through the emitter—base-one diode. Current must fall to 0.74 A within 1.5 ms and pulse-repetition rate must not exceed 10 pps.
3. Derate linearly to 125°C free-air temperature at the rate of 3 mW/°C.

JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication.

USES CHIP U42

# TYPES 2N2646, 2N2647

## P-N PLANAR SILICON UNIJUNCTION TRANSISTORS

\*electrical characteristics at 25°C free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	2N2646		2N2647		UNIT
		MIN	MAX	MIN	MAX	
$r_{BB}$ Static Interbase Resistance	$V_{B2B1} = 3 \text{ V}$ , $I_E = 0$	4.7	9.1	4.7	9.1	$k\Omega$
$\alpha_{rBB}$ Interbase Resistance Temperature Coefficient	$V_{B2B1} = 3 \text{ V}$ , $I_E = 0$ , $T_A = -55^\circ\text{C}$ to $125^\circ\text{C}$ , See Note 4	0.1	0.9	0.1	0.9	$\%/^\circ\text{C}$
$\eta$ Intrinsic Standoff Ratio	$V_{B2B1} = 10 \text{ V}$ , See Figure 1	0.56	0.75	0.68	0.82	
$I_{EB20}$ Emitter Reverse Current	$V_{EB2} = -30 \text{ V}$ , $I_{B1} = 0$		-12		-0.2	$\mu\text{A}$
$I_P$ Peak-Point Emitter Current	$V_{B2B1} = 25 \text{ V}$		5		2	$\mu\text{A}$
$I_V$ Valley-Point Emitter Current	$V_{B2B1} = 20 \text{ V}$	4		8	18	$\text{mA}$
$V_{OB1}$ Base-One Peak Pulse Voltage	See Figure 2	3		6		$\text{V}$

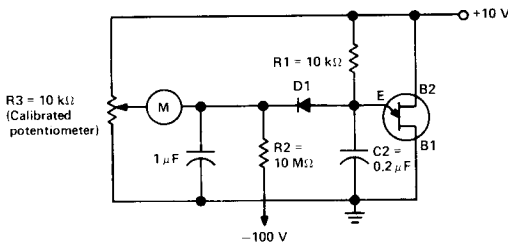
NOTE 4: Temperature coefficient  $\alpha_{rBB}$  is determined by the following formula:

$$\alpha_{rBB} = \left[ \frac{(r_{BB} @ 125^\circ\text{C}) - (r_{BB} @ -55^\circ\text{C})}{r_{BB} @ 25^\circ\text{C}} \right] \frac{100\%}{180\%}$$

To obtain  $r_{BB}$  for a given temperature  $T_A(2)$ , use the following formula:

$$r_{BB}(2) = [r_{BB} @ 25^\circ\text{C}] [1 + (\alpha_{rBB}/100\%)(T_A(2) - 25^\circ\text{C})]$$

### \*PARAMETER MEASUREMENT INFORMATION



$\eta$ —Intrinsic Standoff Ratio—This parameter is defined by the equation:  $V_P = \eta V_{BB} + V_F$ , where  $V_F$  is about 0.67 volts at 25°C and decreases with temperature at about 2 millivolts/°C.

A circuit which may be used to measure  $\eta$  is shown in this figure. In this circuit, R1, C1, and the unijunction transistor form a relaxation oscillator. The remainder of the circuit serves as a peak-voltage detector with the diode D1 automatically subtracting the voltage  $V_F$ . To use the circuit, the calibrated potentiometer R3 is adjusted to null the meter M. The potentiometer is then read directly for  $\eta$ , e.g., 6 k $\Omega$  represents  $\eta = 0.6$ .

D1: Silicon diode with the following characteristics:

$$V_F = 0.672 \text{ V at } I_F = 0.5 \text{ mA}$$

$$I_R \leq 2 \text{ nA at } V_R = 20 \text{ V.}$$

FIGURE 1— $\eta$  TEST CIRCUIT

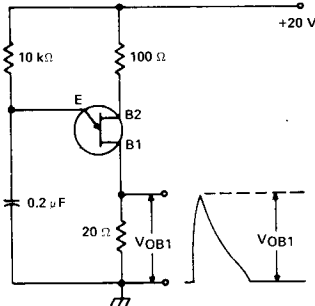


FIGURE 2— $V_{OB1}$  TEST CIRCUIT

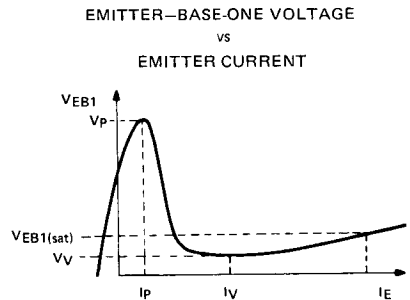


FIGURE 3—GENERAL STATIC EMITTER CHARACTERISTIC CURVE

\*JEDEC registered data